

Notice of References Cited		Application/Control No. 10/632,110	Applicant(s)/Patent Under Reexamination EKIN ET AL.	
		Examiner DAVID CZEKAJ	Art Unit 2621	Page 1 of 1

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B US-6,678,635	01-2004	Tovinkere et al.	702/179
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*	D US-6,810,144	10-2004	McGee et al.	382/166
*	E US-7,027,509	04-2006	Jun et al.	375/240.16
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M	US-			

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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